
Optimum-Path Forest Classifier and Open-Set Optimum-Path Forest Classifier

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Table of contents

Optimum-path forest classifier

Open-set recognition

Open-set optimum-path forest classifier

Open set vs. closed set

Optimum-path forest classifier

Overview

1. Proposed by Papa et al. (2007, 2009) from Unicamp.
2. Generalization of the Image Foresting Transform (IFT).
3. Graph based. Nodes are training samples.
4. Behavior similar to the k NN (see Souza et al. (2014)).
5. Inherently multiclass.
6. Parameter independent.
7. Closed set.
8. Good results in some classification problems.
9. General methodology.

OPF formalization

$$Z = \{(s_1, \theta(s_1)), (s_2, \theta(s_2)), \dots, (s_m, \theta(s_m))\}, \quad (1)$$

whereby

- ▶ s_i , $i = 1, \dots, m$, is a feature vector.
- ▶ $\theta(s_i)$ is the actual class of s_i , i.e., $\theta(s_i) \in \mathcal{L} = \{\ell_1, \ell_2, \dots, \ell_n\}$.
- ▶ \mathcal{L} is a set of labels representing n distinct classes.

OPF formalization

$$S = \{(s_1^P, \theta(s_1^P)), \dots, (s_k^P, \theta(s_k^P))\}, \quad (2)$$

such that

- ▶ $S \subseteq Z$
- ▶ $k \leq m$

- ▶ S is the set of *prototypes*.
- ▶ How to obtain S ?
 - ▶ We are going to see.

OPF formalization

- ▶ Based on Z , we have the complete graph $A = Z \times Z$.
- ▶ Based on S and A , we create an optimum-path forest.
- ▶ Each tree of the forest is rooted in a sample in S .

- ▶ What is an optimum-path forest?
 - ▶ What is an optimum path?
 - ▶ How to measure a path?
- ▶ How to create the optimum-path forest?

Optimum-path forest creation

How to create the optimum-path forest?

- ▶ Based on the IFT algorithm.
 - ▶ It is similar to Dijkstra's algorithm.
 - ▶ It is for multi-sources.
 - ▶ S is the set of sources.

OPF's path cost function

How to measure a path?

$$f_{cost}(\langle s \rangle) = \begin{cases} 0 & \text{if } s \in S \\ +\infty & \text{otherwise,} \end{cases}$$
$$f_{cost}(\pi_{s,u} \cdot (u, t)) = \max\{f_{cost}(\pi_{s,u}), w(u, t)\}. \quad (3)$$

whereby

- ▶ $\pi_{s,u} \cdot (u, t)$ denotes the concatenation of a path $\pi_{s,u}$ ending at u and an arc (u, t) .
- ▶ $w(s, t)$ denotes the Euclidean distance between s and t in the feature space.

Optimum-path definition

What is an optimum path?

- ▶ A path $\pi_{s,t}$ with terminus t is said optimum if
 - ▶ $f_{cost}(\pi_{s,t}) \leq f_{cost}(\pi_{u,t})$ for all $u \in Z$.
- ▶ We say that $P^*(t) = \pi_{s,t}$.

Optimum-path forest definition

What is an optimum-path forest?

- ▶ Every optimum path is from $s \in S$, $S \subseteq Z$, according to the f_{cost} .

- ▶ Now, we know $P^*(t)$ for every sample $t \in Z$.
- ▶ Then, every sample t holds its minimum cost $C(t)$:

$$C(t) = f_{cost}(P^*(t)) \quad (4)$$

Defining S

How to obtain S ?

- ▶ Create the Minimum Spanning Tree (MST) of $A = Z \times Z$.
- ▶ $S = \{s \text{ such that } s \in Z \text{ and } \theta(s) \neq \theta(t) \text{ for some } t \in N(s)\}$
whereby $N(s)$ are the neighbors of s in the MST.

Algorithm 1 OPF algorithm.

Require: Set of training samples Z

Require: Set of prototypes S

Ensure: $S \subseteq Z$

Output: Optimum-path forest P

Output: Cost map C

Output: Label map L

for all $s \in Z \setminus S$ **do**

$C(s) \leftarrow +\infty$

end for

for all $s \in S$ **do**

$C(s) \leftarrow 0$; $P(s) \leftarrow nil$; $L(s) \leftarrow \theta(s)$

 Insert s in Q

end for

while Q is not empty **do**

 Remove s from Q such that $C(s) \leq C(t)$ for all $t \in Q$, $s \neq t$

for all $t \in Z$ such that $s \neq t$ **do**

$cst \leftarrow \max\{C(s), w(s, t)\}$

if $cst < C(t)$ **then**

if $C(t) \neq +\infty$ **then**

 Remove t from Q

end if

$P(t) \leftarrow s$; $L(t) \leftarrow L(s)$; $C(t) \leftarrow cst$

 Insert t in Q

end if

end for

end while

Prediction phase

$$L(s) = L(\mathcal{R}(\arg \min_{\forall t \in Z} \{\max\{C(t), w(s, t)\}\})) \quad (5)$$

whereby

- ▶ $\mathcal{R}(s) \in S$ is the root of the tree.
- ▶ $L(s)$ is the predicted class of the sample s .

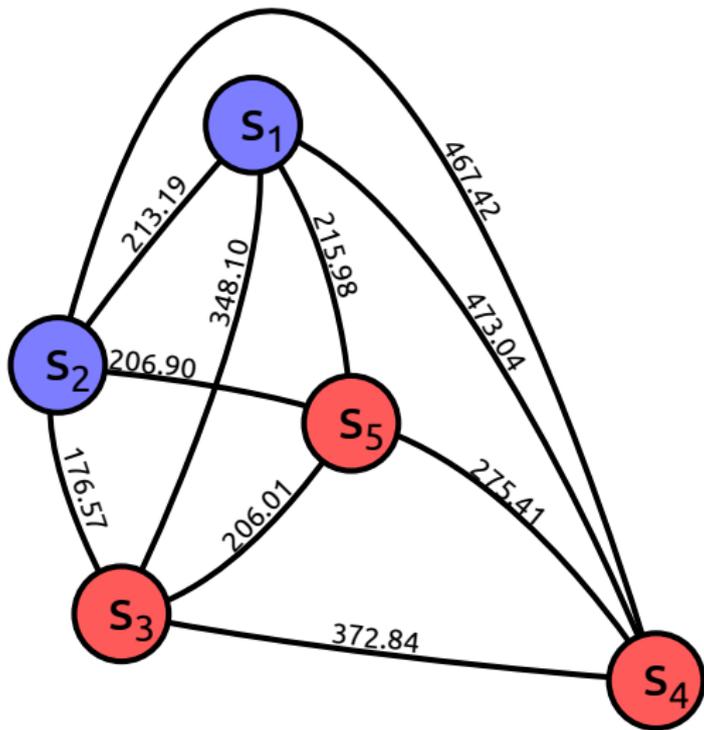
S_1

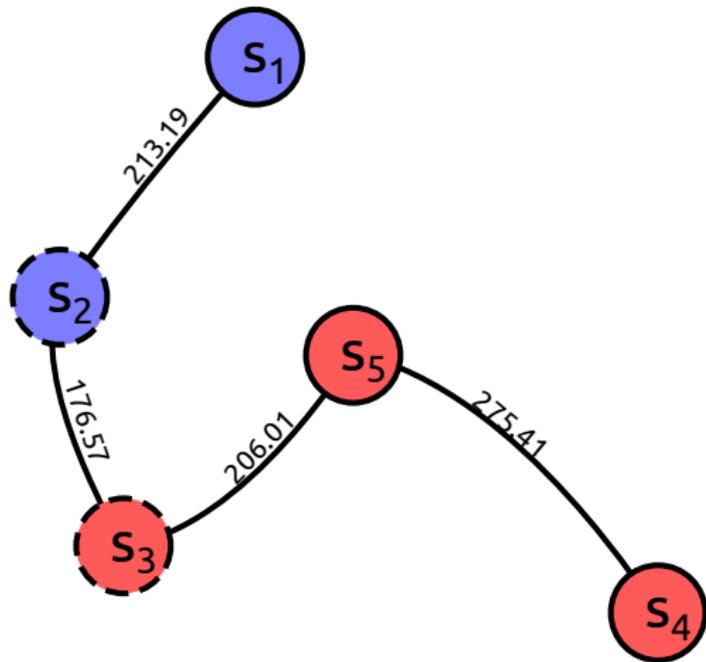
S_2

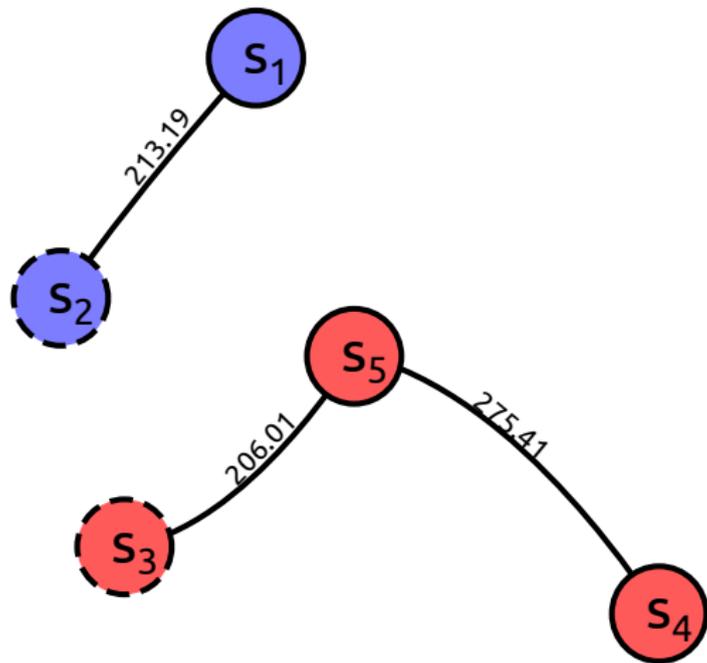
S_5

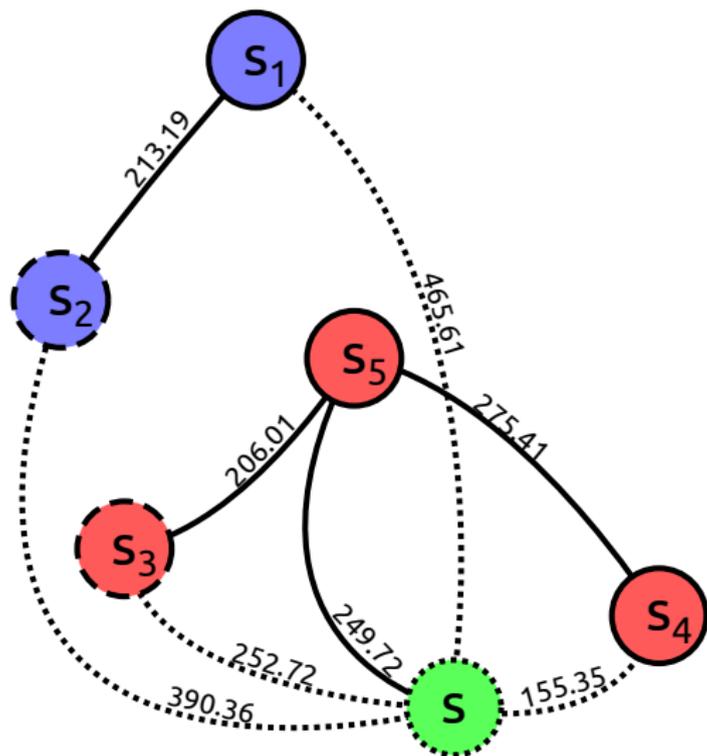
S_3

S_4









Open-set recognition

Open-set recognition problem

- ▶ Recognition vs. classification
- ▶ A **limited amount of classes** are available for training

Openness of a problem (Scheirer et al., 2013)

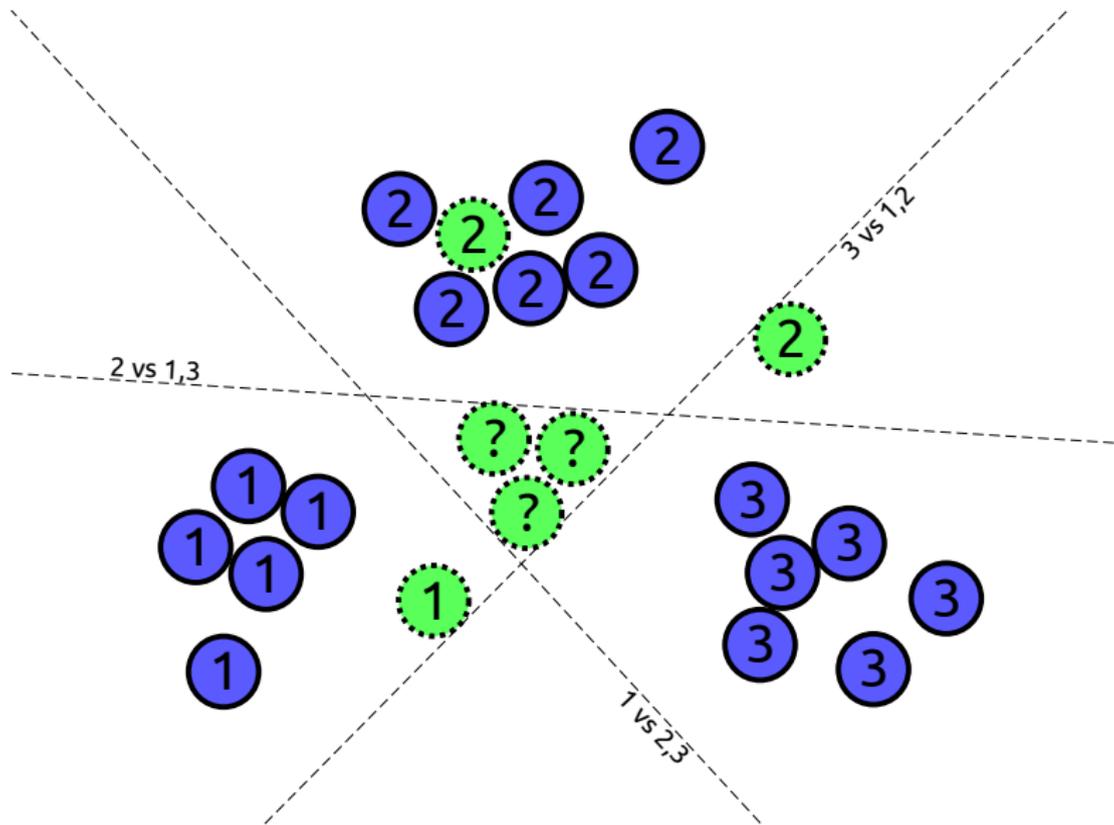
$$openness = 1 - \sqrt{\frac{|\text{training classes}|}{|\text{testing classes}|}}$$

Types of error

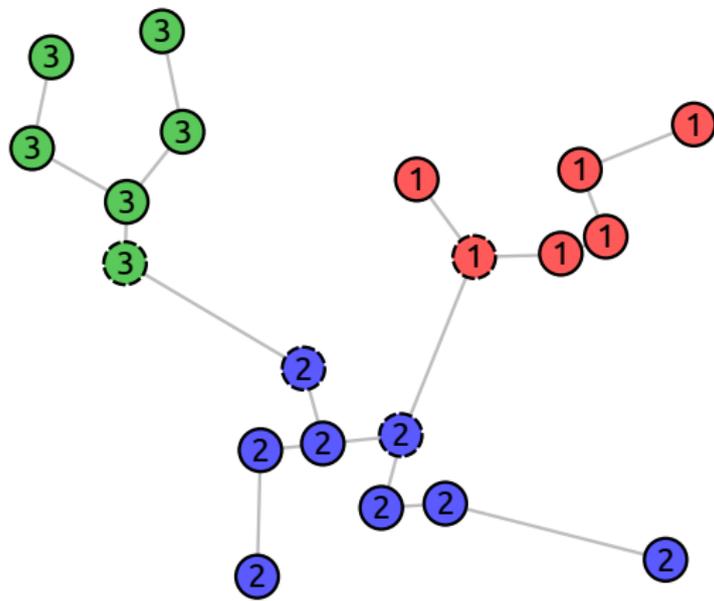
- ▶ Misclassification
- ▶ False unknown
- ▶ False known

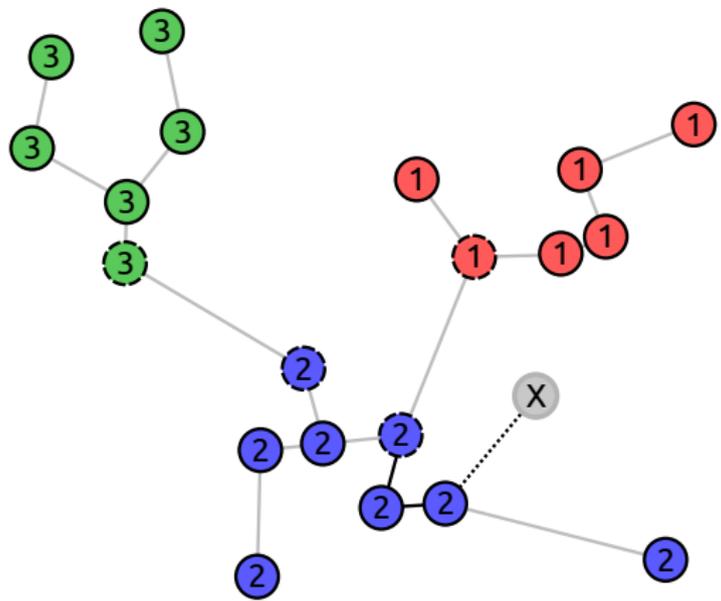
Traditional approach

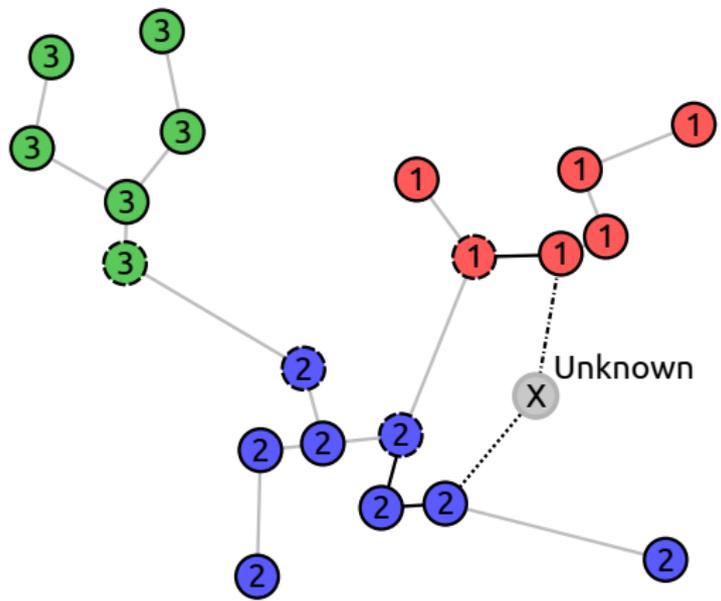
- ▶ **Threshold** on the best similarity score
- ▶ Multiclass-from-binary SVM using one-vs-all approach

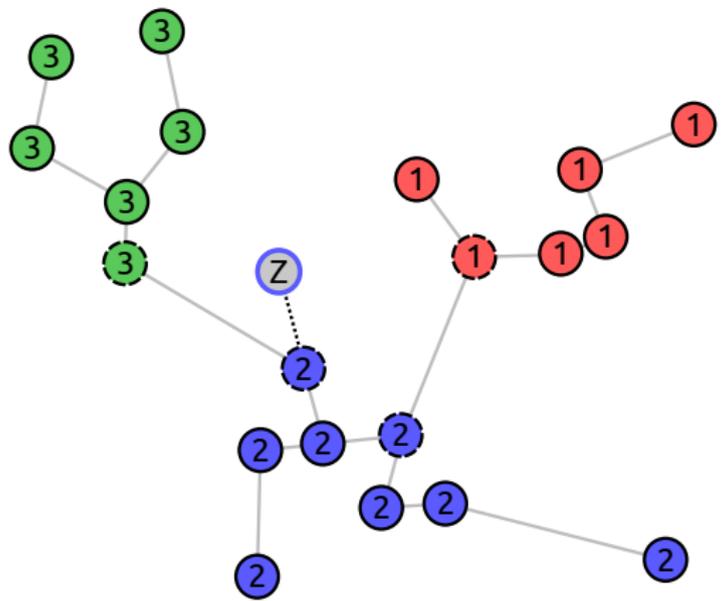


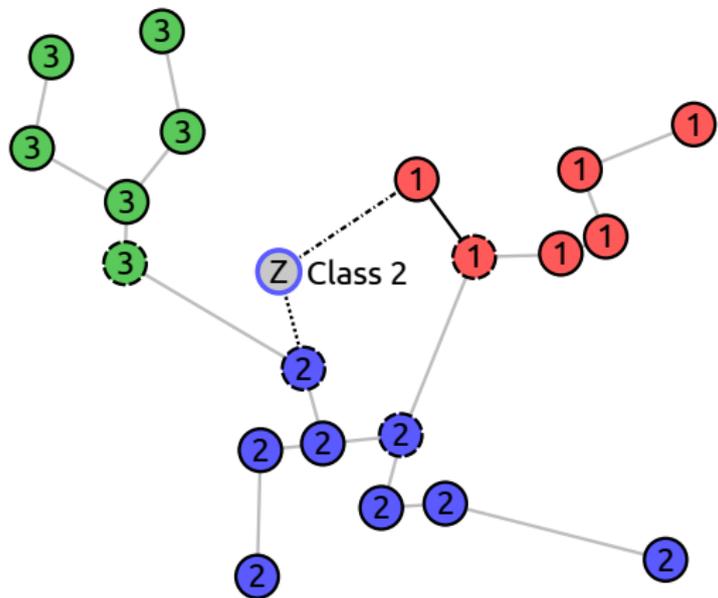
Open-set optimum-path forest classifier

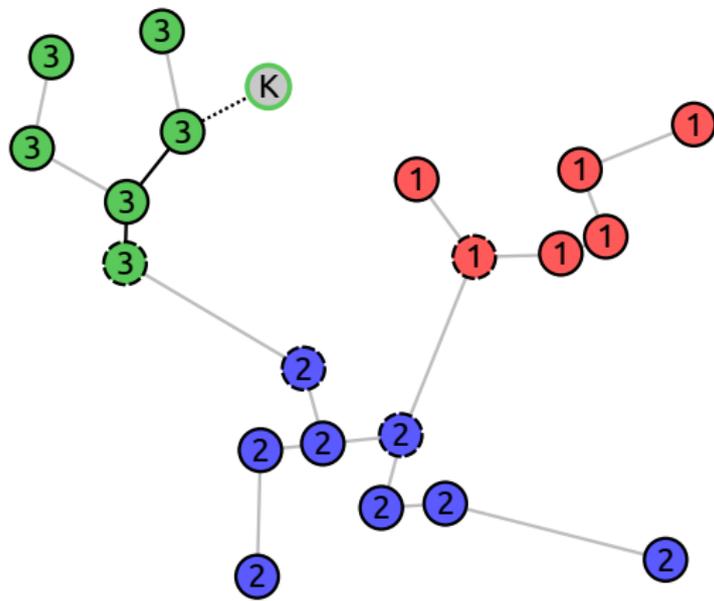


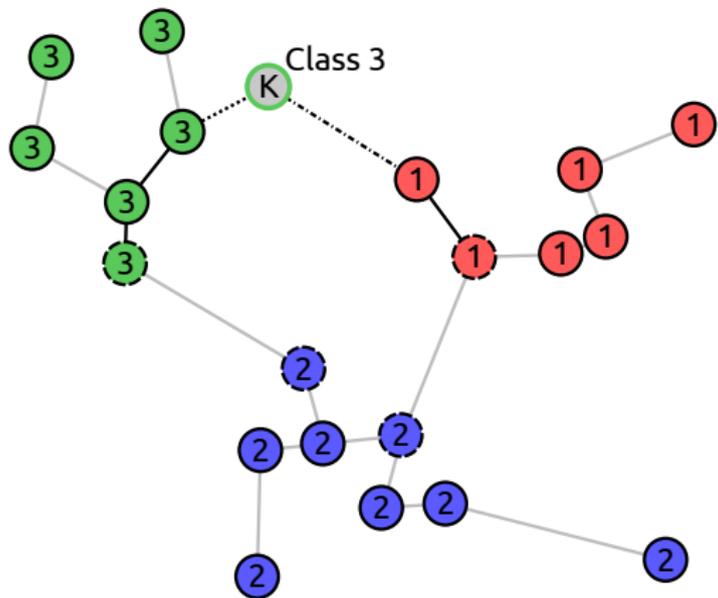


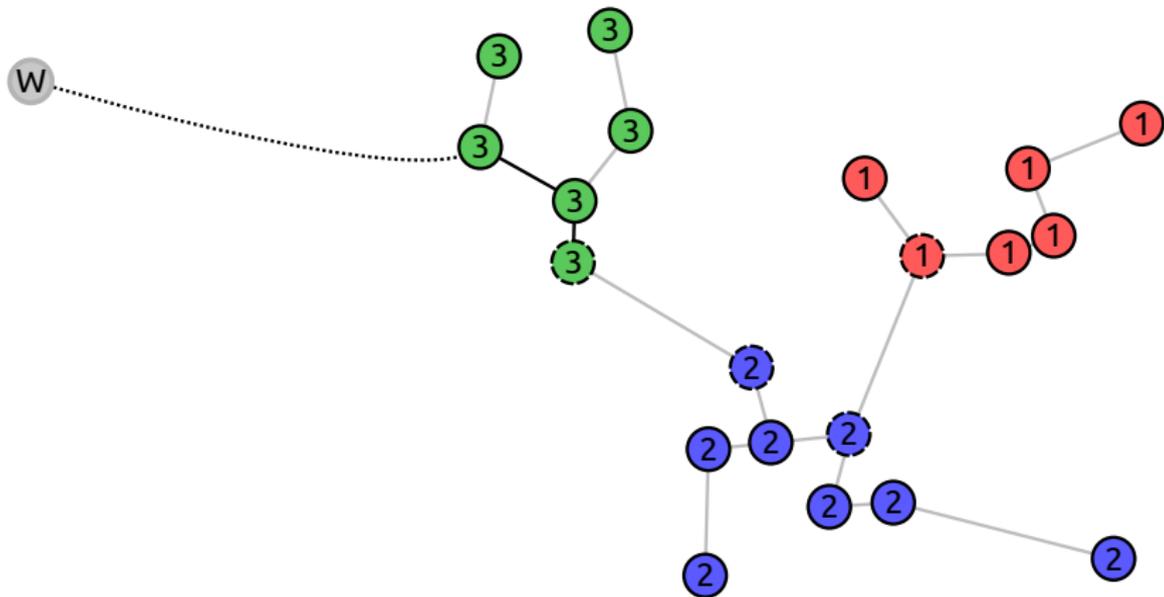


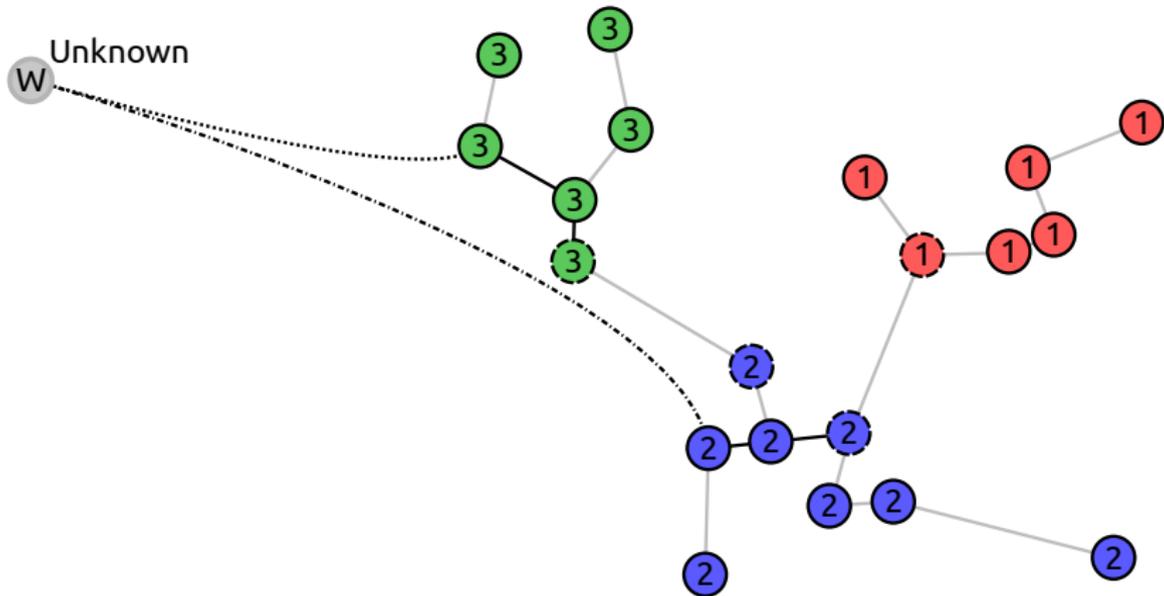






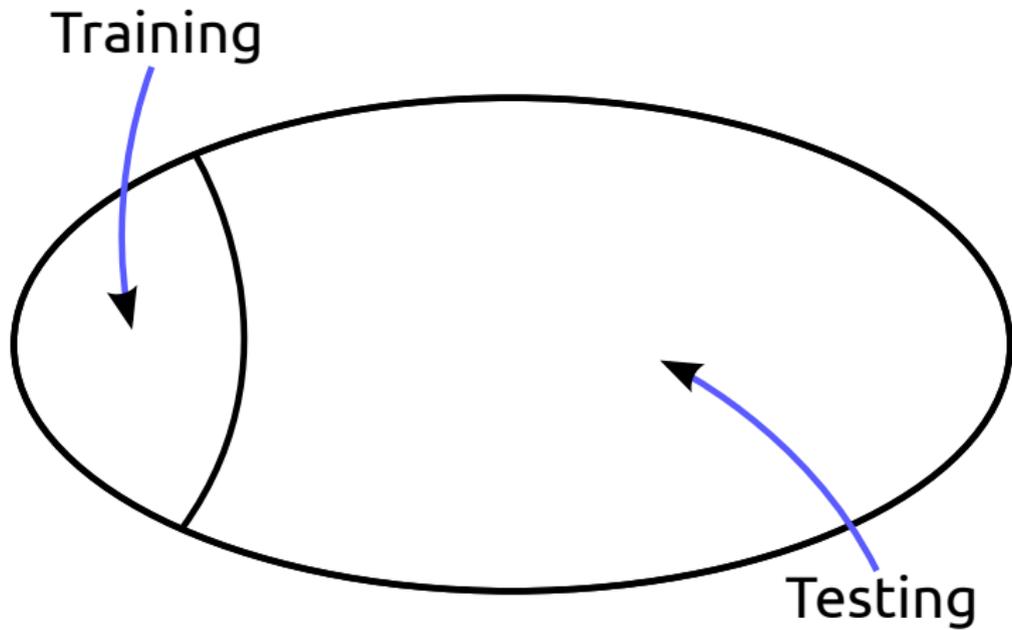


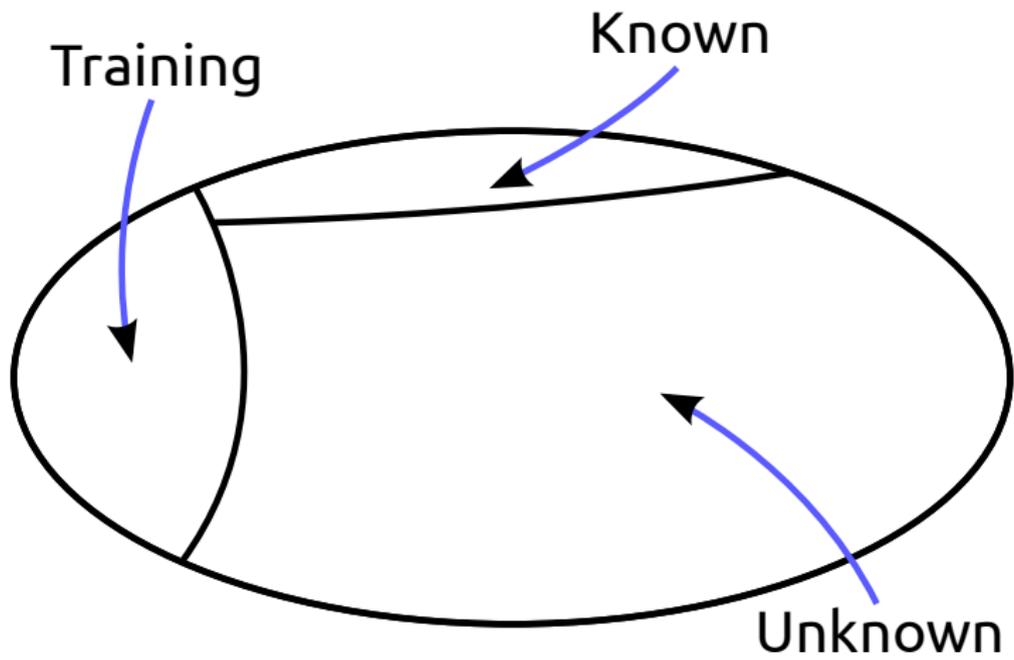


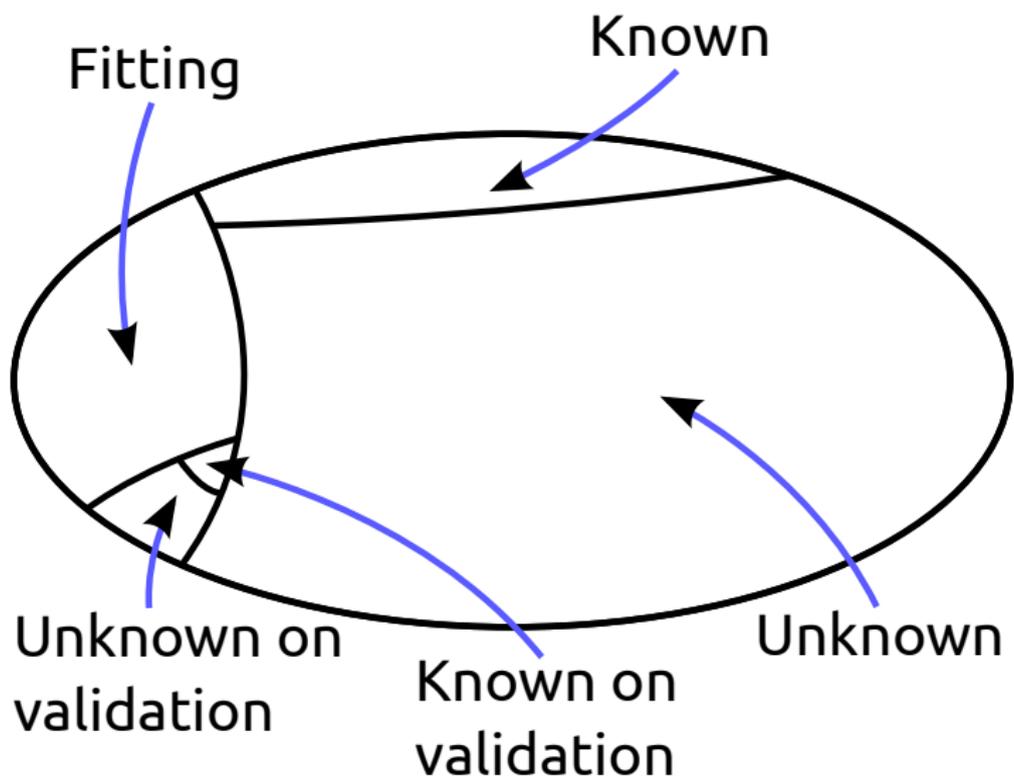


Parameter optimization of OSOPF²

- ▶ Find the threshold T
- ▶ Simulation of the open-set scenario

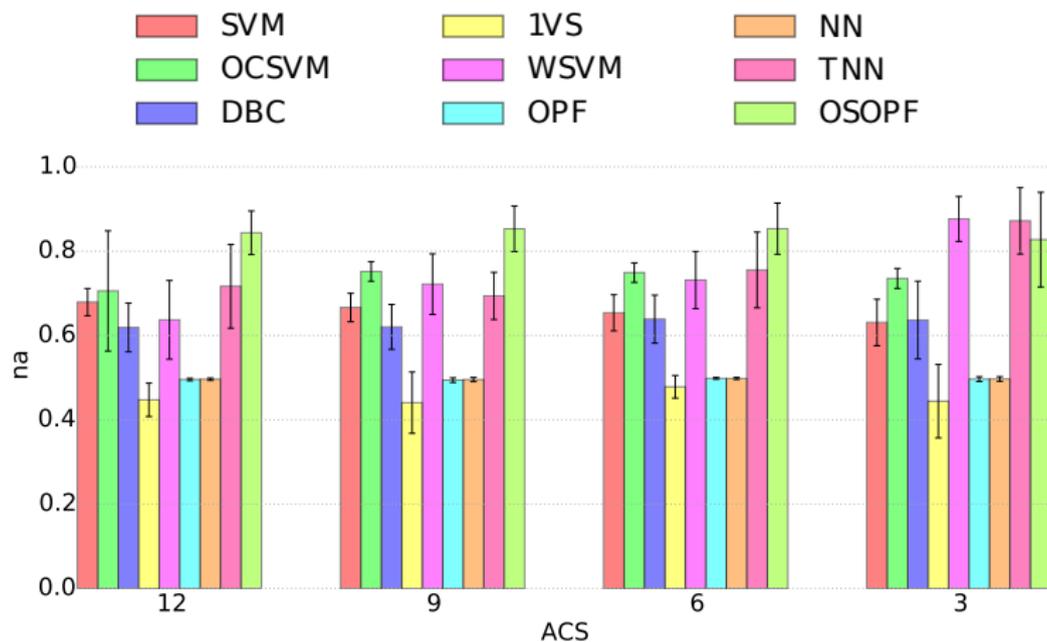




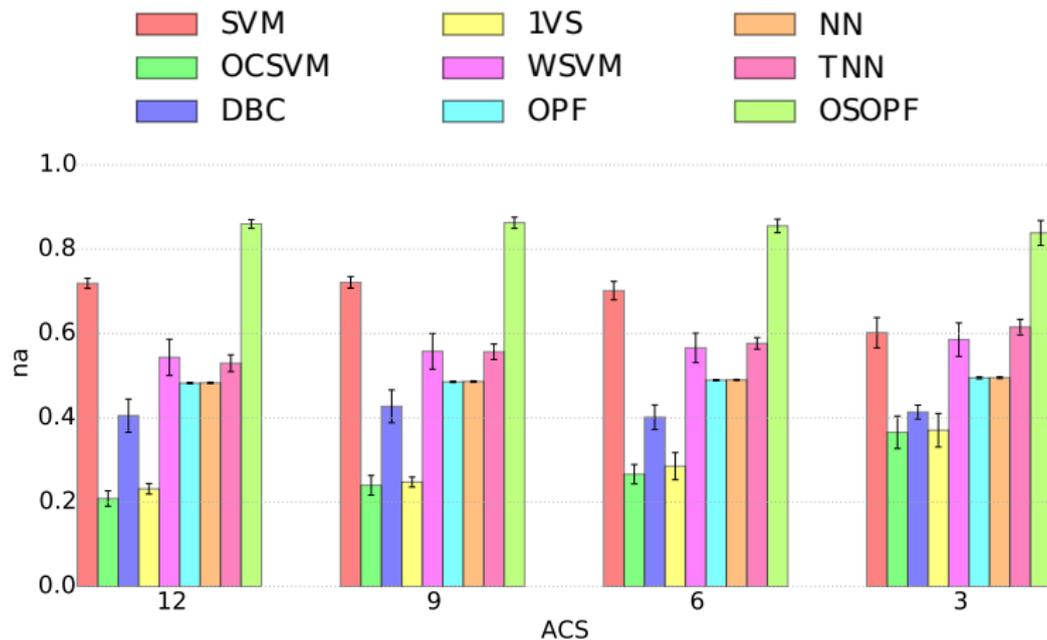


Open set vs. closed set

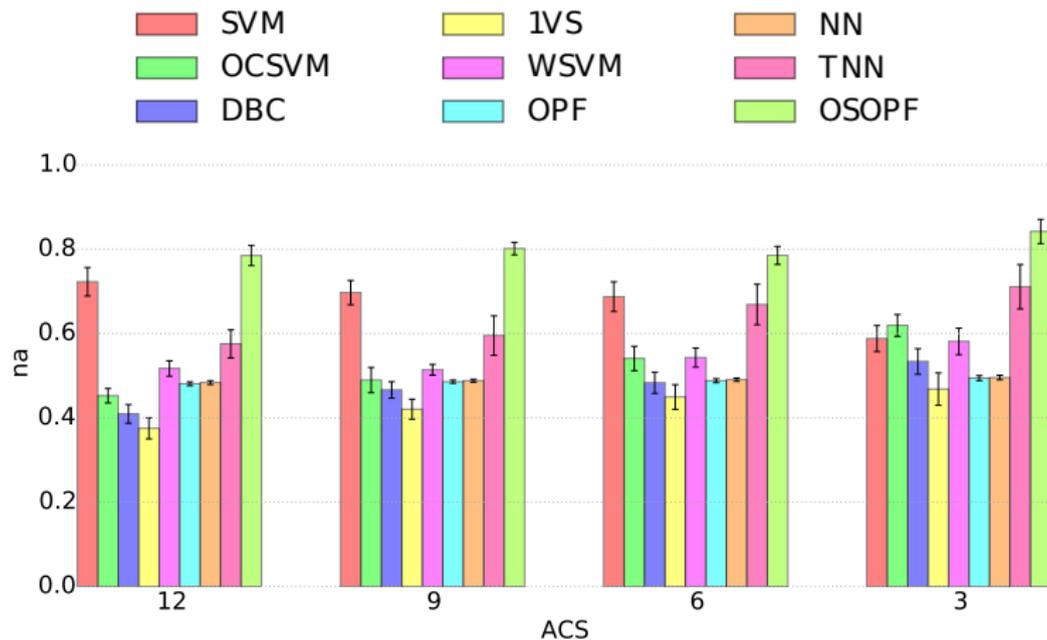
Classification performance – *ALOI* – NA



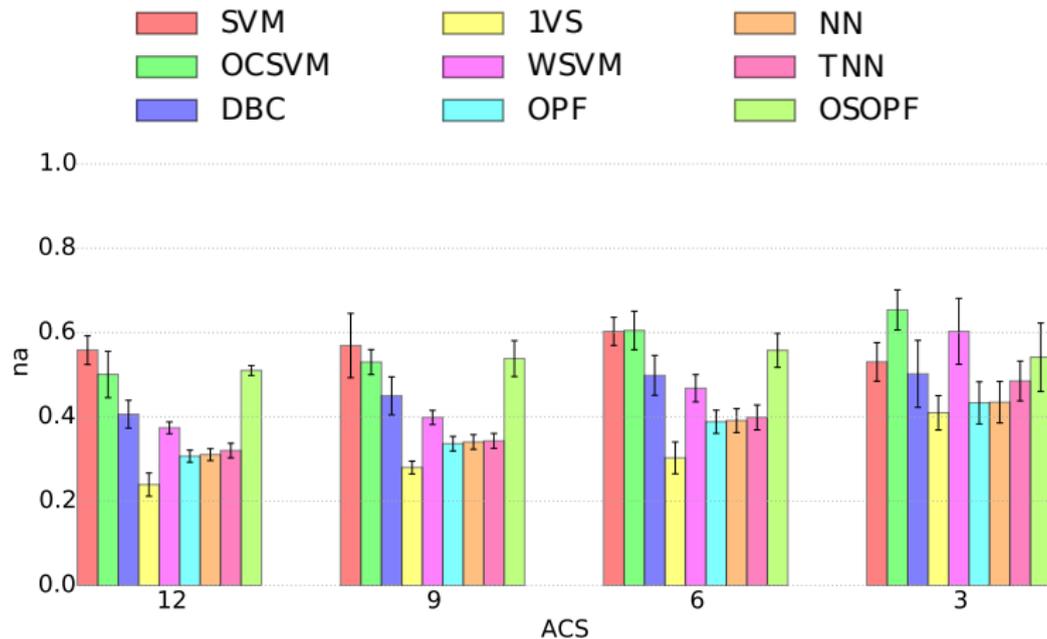
Classification performance – *Auslan* – NA



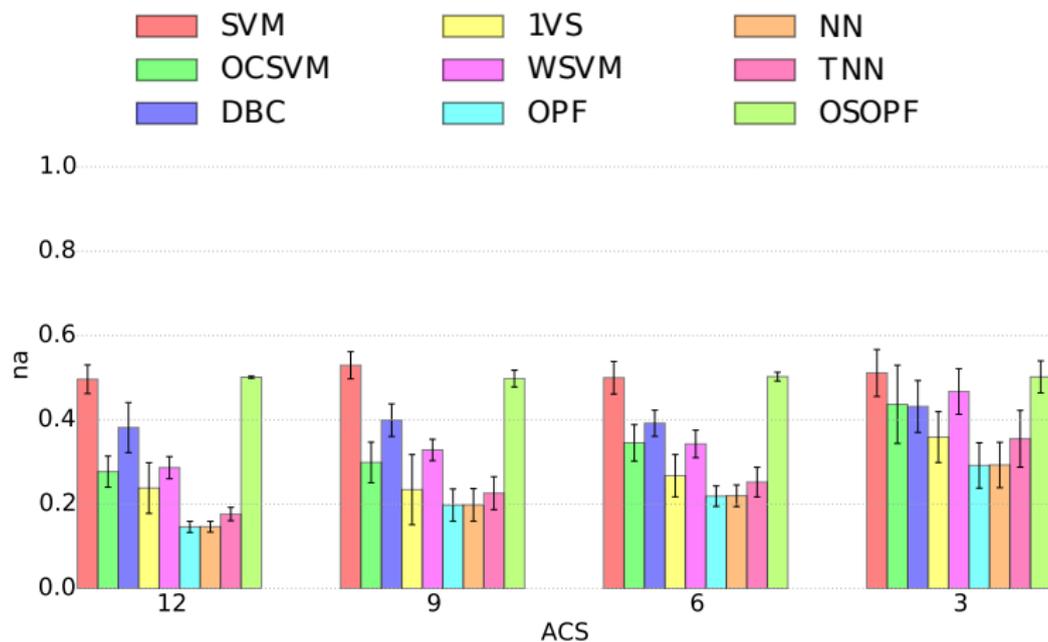
Classification performance – letter – NA



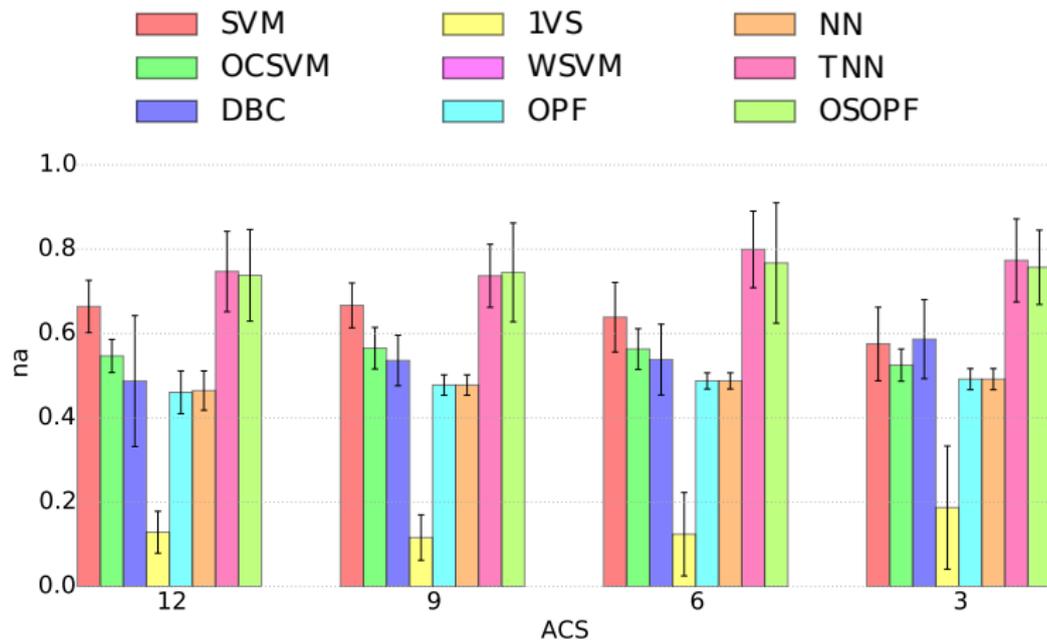
Classification performance – 15-Scene – NA

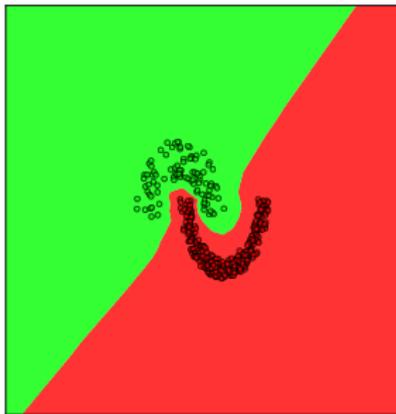


Classification performance – Caltech-256 – NA

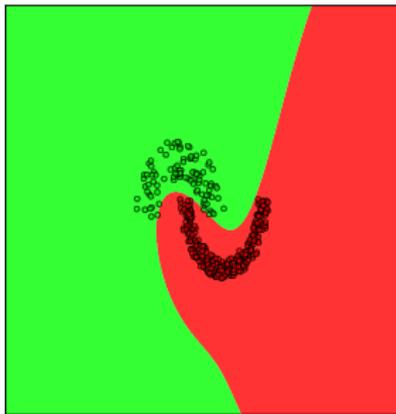


Classification performance – *ukbench* – NA

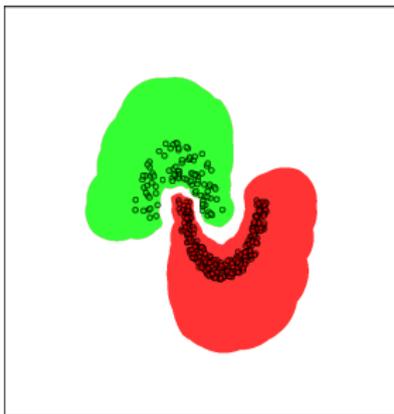




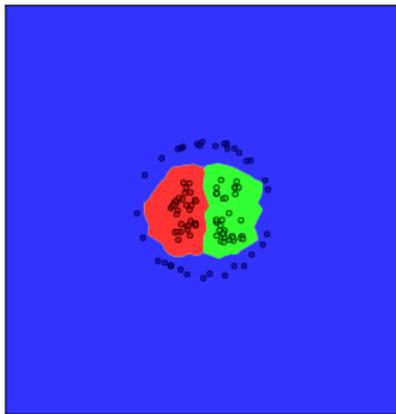
(a) OPF



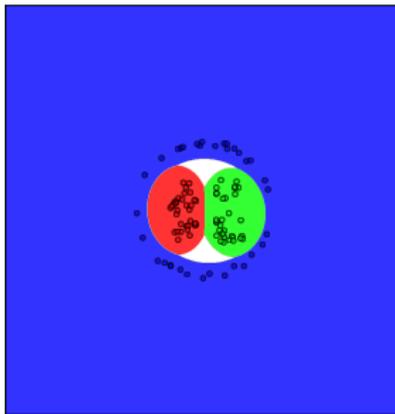
(b) SVM



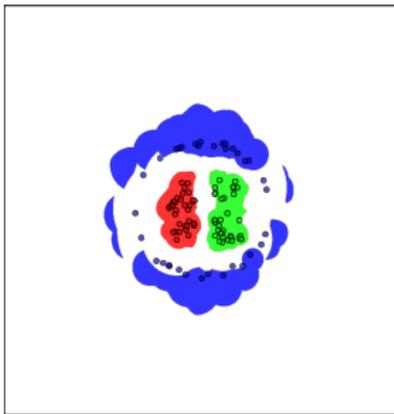
(c) OSOPF



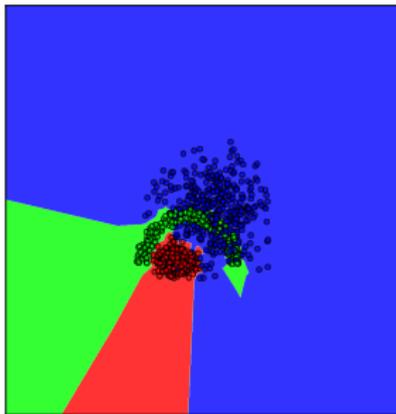
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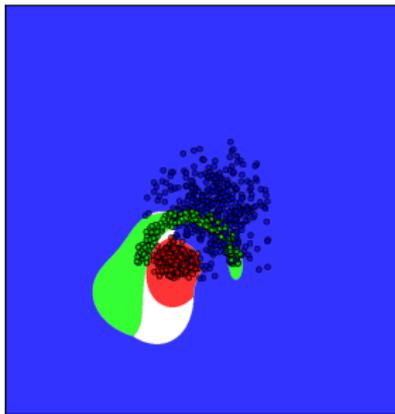
(b) SVM



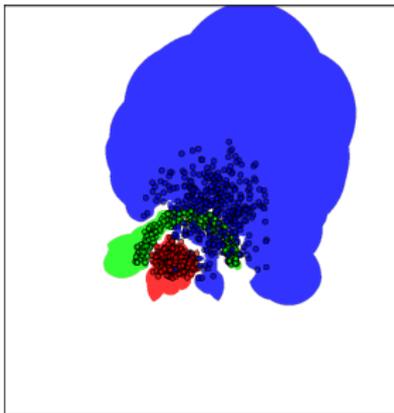
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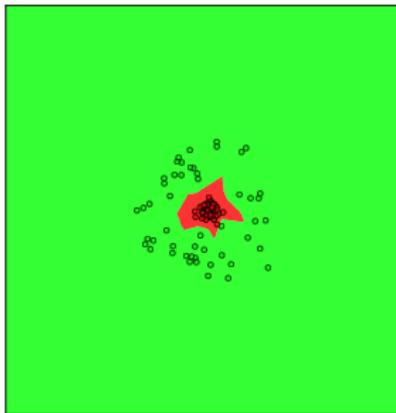
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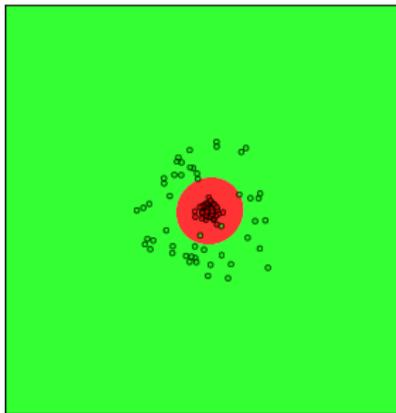
(b) SVM



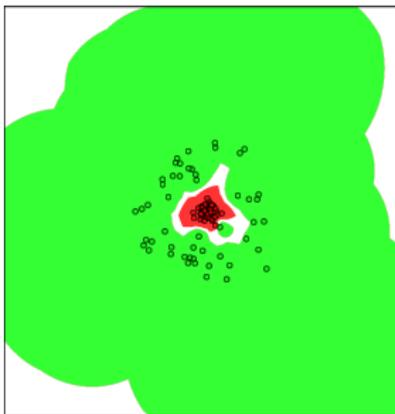
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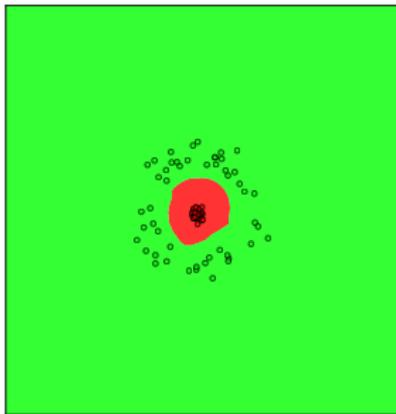
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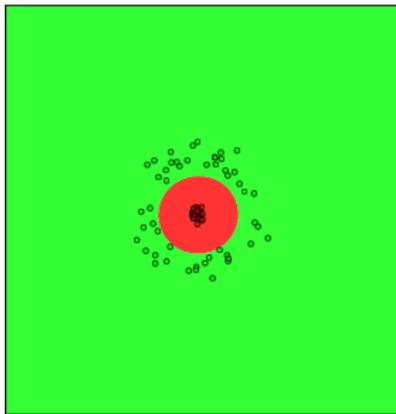
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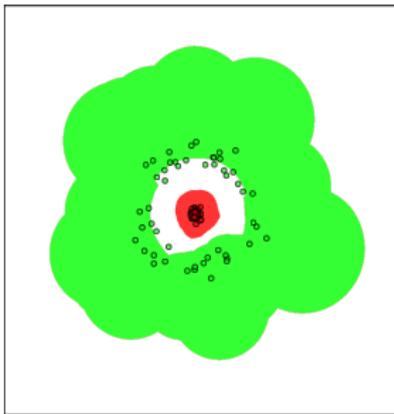
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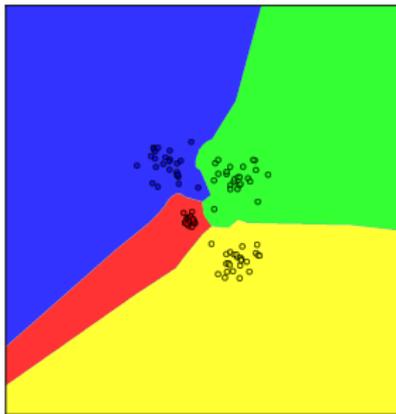
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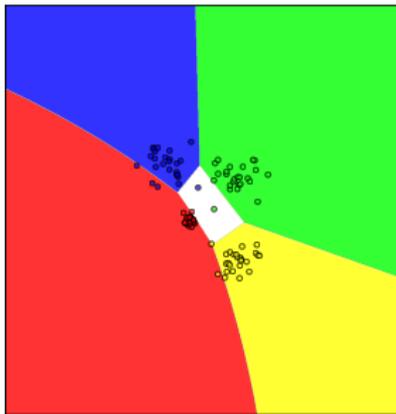
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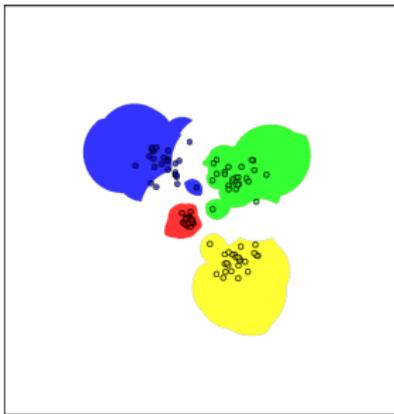
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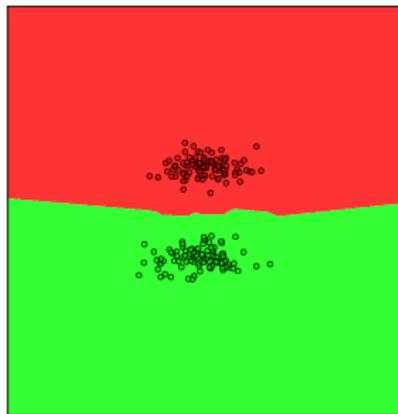
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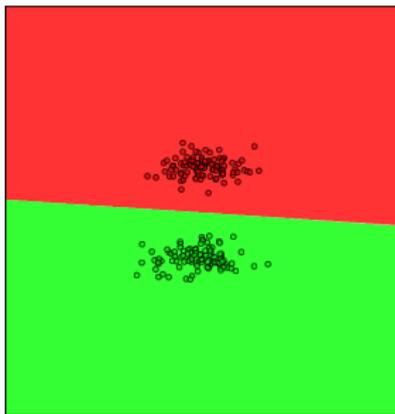
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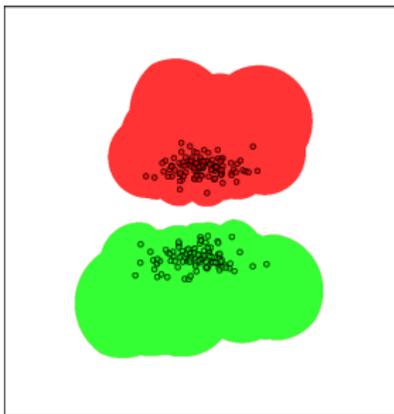
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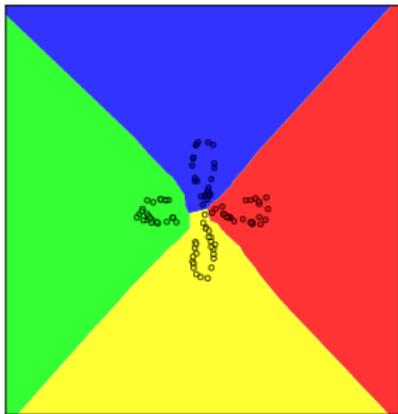
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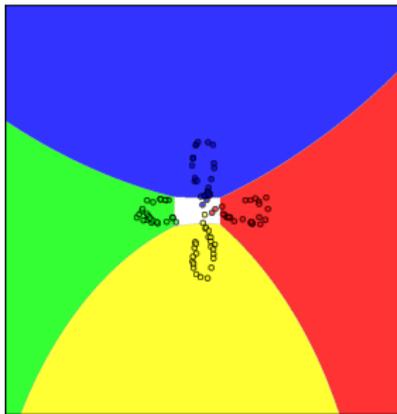
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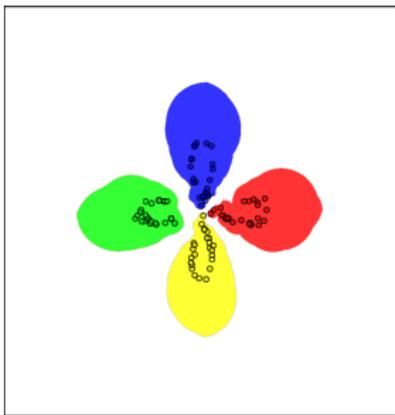
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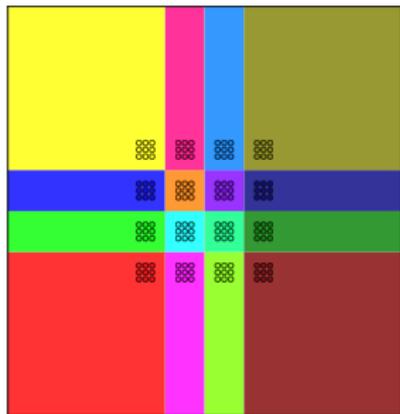
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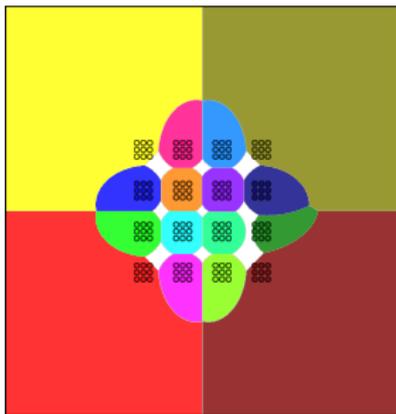
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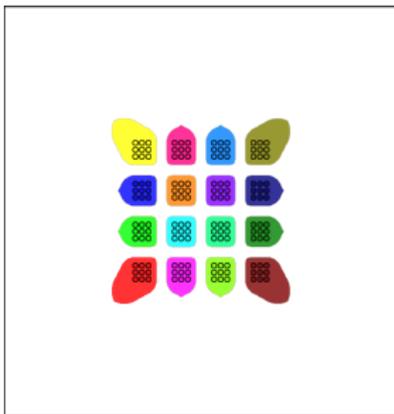
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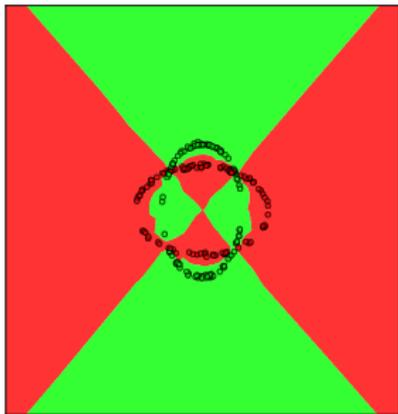
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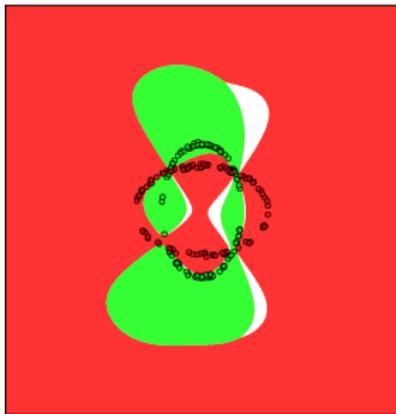
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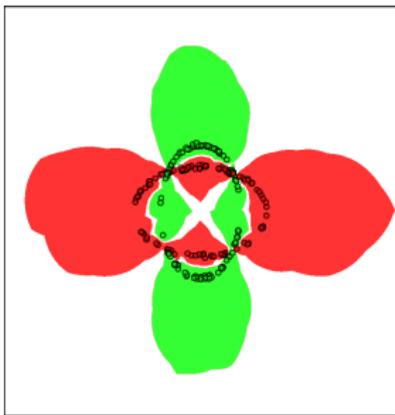
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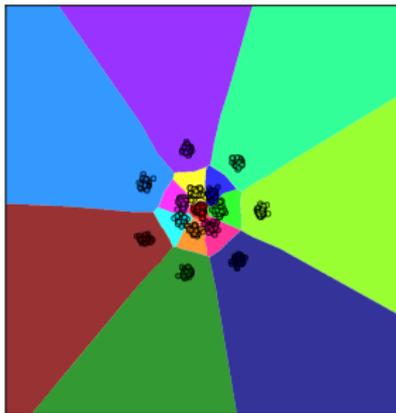
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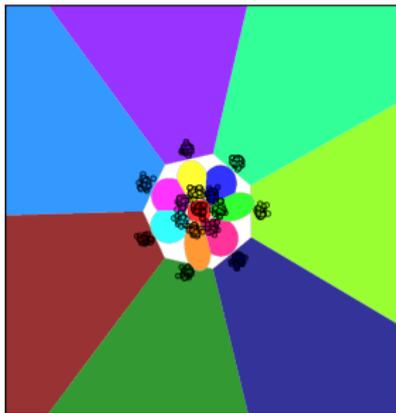
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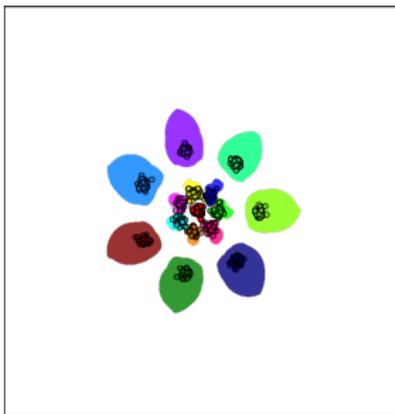
(c) OSOPF



(a) OPF



(b) SVM



(c) OSOPF

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